Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	ent under	
09/620,772	KAHN ET AL.		
Examiner	Art Unit		
Ellen C. Tran	2134		

	SEARCHED		
Class	Subclass	Date	Examiner
726	26	8/8/2006	ECT

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC		")
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	8/8/2006	ECT